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(11) EP 1 162 450 A1

(12) EUROPEAN PATENT APPLICATION

(43) Date of publication:  
12.12.2001 Bulletin 2001/50

(51) Int Cl.7: G01N 21/64, G02B 21/16

(21) Application number: 00810496.0

(22) Date of filing: 07.06.2000

(84) Designated Contracting States:  
AT BE CH CY DE DK ES FI FR GB GR IE IT LI LU  
MC NL PT SE  
Designated Extension States:  
AL LT LV MK RO SI

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(54) Reference device for evaluating the performance of a confocal laser scanning microscope, and a method and system for performing that evaluation

(57) A reference device for evaluating the performance of a confocal laser scan microscope. The reference device comprises a substrate (53) and reference

fluorescing matter distributed over a surface of the substrate (53). The reference fluorescing matter has a predetermined spatial distribution over the latter surface.

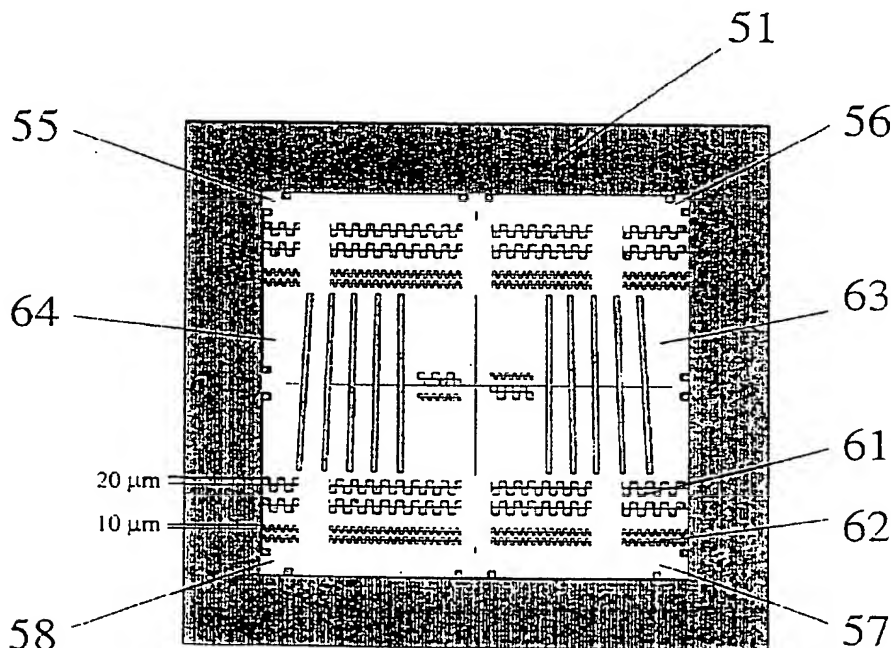


Fig. 7a

## Description

Field of the Invention

5 [0001] The invention concerns a reference device for evaluating the performance of a confocal laser scan microscope of the kind used for performing a two dimensional quantitative fluorescence measurement of test matter distributed on a flat surface of a first glass substrate in particular a DNA binding array or the like, e.g. a DNA binding array of the type described in U.S. Patent No.5,143,854.

[0002] The invention also concerns a method for evaluating the performance of a confocal laser scan microscope of the above mentioned kind.

10 [0003] The invention more in particular concerns an evaluation method enabling the calibration and characterization of a confocal laser scan microscope of the above mentioned kind in terms of quantitative signal detection sensitivity, uniformity of the confocal volume over the scan field of view, spatial resolution of the scanning process and dynamic behavior of the measured signal over the scan field of view, said measured signal corresponding to the fluorescent light received.

15 [0004] The invention further concerns a system for evaluating the performance of a confocal laser scan microscope which is apt to be used for performing a two dimensional quantitative fluorescence measurement of test matter distributed on a flat surface of a substrate.

20 Background

[0005] The principle of confocal laser scan microscopy for two-dimensional, quantitative fluorescence measurement is illustrated in Figs. 1 and 2. Figure 1 shows the optical setup of a 2-D flying spot confocal laser scan microscope, using for fluorescence excitation a laser beam 11, a dichroic beamsplitter 12, a 2-dimensional scan engine 13 for spatial beam deflection in two orthogonal directions (X-Y) and a lens 14 for focusing the laser beam into an object plane 15. Fluorescent light of a longer wavelength than the excitation laser 11 is generated by exciting fluorescent molecules in the object plane 15.

[0006] Fluorescent light emitted by fluorophores located in the scanned area/volume in the object plane 15 is collected by lens 14 and then transmitted by means of the scan engine 13 and the dichroic beamsplitter 12 as a fluorescent light beam 17 which is focused by lens 18 into a pinhole aperture 19 in a conjugate plane 21 in front of a photodetection device 22.

30 [0007] The concept of confocal imaging, which is currently used to discriminate the generally weak fluorescence signal from background radiation, is illustrated in Fig. 2. Only optical radiation from within the confocal volume  $V_c$ , i. e., the fluorescence signal, is detected by the photodetector 22.  $V_c$  is defined by the optical transfer function of the detection optics (OTFem) and the size of the detector pinhole 19 in the conjugate plane 21. Higher background suppression rates result for smaller confocal volumes  $V_c$ .

35 [0008] The size of the scan field of view is typically in the order of 20 x 20 square millimeter. The confocal volume is generally in the order of  $V_c = 5 \times 5 \times 50$  cubic micrometer, where  $A_c = 5 \times 5$  square micrometer and  $z_c = 50$  micrometer is approximately the spot size and the Rayleigh range of the focused laser beam, respectively. The pixel size of the scan engine 13 for scanning the laser beam 11 in the field of view is typically 1 to 20 micrometer.

40 [0009] DNA binding arrays, e.g. those of the type described in U.S. Patent No.5,143,854, consist of a glass chip carrying a chemical system subdivided in adjacent cells, commonly called features. The features are characterized by specific probes. Specific nucleic acid sequences are immobilized (captured) by the probes and labeled with a fluorescent dye. The amount of captured nucleic acid on individual features is detected using quantitative fluorescence measurement (the fluorescent dye emits light when excited by light energy of a given wavelength) by sequential pixel reading (scanning) of the features. The features are spatially over-sampled by the scanning procedure (i.e. number of pixels > number of features) for accurate spatial referencing of the glass chip by numerical data analysis and for increased feature signal quality by averaging physically measured light intensities. Typical pixel sizes are in the order of 1 to 20 micrometer.

45 [0010] The typically high ratio scan field of view / cross-section  $A_c$  of the confocal volume  $\gg 1$  in confocal laser scan microscopy readily leads to a x-y position depending optical transfer function  $OTF(x, y) = OTF_{ex} * OTF_{em}$ , where  $OTF_{ex}$  and  $OTF_{em}$  are the optical transfer functions of the excitation and emission optics, respectively, which is mainly due to mechanical misalignment and imperfections of optical and opto-mechanical components. This causes an inhomogeneous sensitivity over the scan field of view, as schematically sketched in Figures 3a, 3b and 3c and this in turn leads to erroneous quantitative fluorescence measurement. As an example, Fig. 4 schematically shows the scanned image of a DNA binding array, e.g. of the type described in U.S. Patent No.5,143,854, which array has a chess-board pattern. As described hereinafter with reference to Fig. 4 the scanned image has a lower signal level in the top right corner, due to either inhomogeneous fluorophore density in the scanned object or inhomogeneous sensitivity of the

confocal laser scan microscope over the scan field of view.

[0011] There is therefore a need for a reliable quantitative measurement and evaluation of the sensitivity over the scan field of view of a confocal laser scan microscope of the above described type.

[0012] The availability of an appropriate reference standard target object would allow to discriminate between instrument- and scanned object (e.g. a DNA binding array of the type described in U.S. Patent No.5,143,854) contributions to the observed non-uniformity in Fig. 4. However, no reference fluorescing target objects for calibrating and characterizing key performances of a confocal laser scan microscope, i.e., sensitivity, uniformity-, spatial resolution- and signal dynamic behavior over the scan field of view, have been reported yet.

[0013] There is therefore a need for an appropriate reference standard target object that allows to discriminate between instrument- and scanned object contributions to a non-uniformity of the type represented in Fig. 4.

### **Summary of the Invention**

[0014] The aim of the invention is therefore to provide a reference device, a method and a system of the above mentioned kinds that make possible to evaluate the performance and to calibrate a confocal laser scan microscope for performing two-dimensional, quantitative fluorescence measurements.

[0015] According to a first aspect of the invention this aim is attained with a reference device comprising the features defined by claim 1.

[0016] According to a second aspect of the invention the above mentioned aim is attained with a method as defined by claim 4.

[0017] According to a third aspect of the invention the above mentioned aim is attained with a system as defined by claim 6.

[0018] The main advantages attained with a reference device, method, and system according to the invention are that they allow a quantitative and highly accurate evaluation of the performance of a confocal laser microscope for scanning DNA binding arrays of the above mentioned kind, and that this evaluation makes it possible to calibrate measurement results obtained by scanning with such a microscope e.g. a sample DNA binding array to be analyzed. In this context it is important to note that the evaluation performed according to the invention includes the measurement of the following characteristics:

- a) quantitative signal detection sensitivity,
- b) uniformity of the confocal volume over the scan field of view,
- c) spatial resolution of the scanning process, and
- d) dynamic behavior of the measured signal over the scan field of view, said measured signal corresponding to the fluorescent light received.

### **Brief Description of the Drawings**

[0019] Preferred embodiments of the invention are described hereinafter with reference to the accompanying drawings wherein:

- Fig. 1 shows a schematic representation of the basic setup of a confocal laser scan microscope for performing a two-dimensional, quantitative fluorescence measurement,
- Fig. 2 schematically shows a confocal volume  $V_c$  in an object plane,
- Figures 3a, 3b and 3c show schematic representations of various forms of non-uniformity of the scanned confocal volume over the scan field of view,
- Fig. 4 shows a schematic representation of a scanned image of a DNA binding array
- Fig. 5a shows a top view of a first embodiment of a reference target device according to the invention,
- Fig. 5b shows a cross-section through a plane A-A of the embodiment shown by Fig. 5a,
- Fig. 6 shows the shape of an electrical signal representative of and obtained by measuring fluorescent light emitted by fluorescent zones located in a row of the array represented in Figures 5a and 5b.

Fig. 7a shows a top view of a second embodiment of a reference target device according to the invention,

Fig. 7b shows a cross-section of the embodiment shown by Fig. 7a.

### Detailed Description of the Invention

[0020] The subject invention will now be described in terms of its preferred embodiments. These embodiments are set forth to aid the understanding of the invention, but are not to be construed as limiting.

[0021] Fig. 1 schematically shows a basic setup of a confocal laser scan microscope for two-dimensional, quantitative fluorescence measurement in case of a two-dimensional flying spot. An excitation laser beam 11, which is transmitted through a dichroic beam splitter 12, is spatially scanned by means of a two-axis scan engine 13, e.g., a galvo-scanner, in two axis X, Y, perpendicular to each other, and is focused by a lens 14 into an object plane 15 which is parallel to a X-Y-plane defined by the axis X and Y, and which is perpendicular to a third axis Z which perpendicular to the X-Y-plane.

[0022] Fluorophores within the confocal volume Vc in the object plane 15 are excited by the focused laser spot 16 and the fluorescent light 17 generated by excitation of those fluorophores is collected and imaged by a lens 18 into a detector pinhole 19 in the conjugate plane 21 and detected by photodetector 22.

[0023] Fig. 2 schematically shows a confocal volume Vc (with  $V_c = A_c \cdot z_c$ ) in the object plane 15. Confocal volume Vc is ideally a cylindrical volume having a rotation axis parallel to the Z axis and a circular cross-section. The confocal volume Vc is defined by the optical transfer function (OTFem) of the detection optics and the size and the shape of the detector pinhole 19 in the conjugate plane 21. Only optical radiation from within the confocal volume Vc is detected by the photodetector 22. The concept of confocal imaging allows high background suppression rates for detecting weak signal levels, as is commonly the case in fluorescence measurements.

[0024] Figures 3a, 3b and 3c show schematic representations in the plane Y-Z of various forms of non-uniformity of the scanned confocal volume Vc, that is of deviations of the shape of this volume from the ideal shape represented in Fig. 2. These deviations cause inhomogenities of the amplitude of the fluorescent light intensity signal measured over the scanned area.

[0025] Fig. 3a shows a scanned confocal volume 24 which is tilted with respect to an ideal or nominal confocal volume 23. Fig. 3b shows a scanned confocal volume 25 which has not a constant width and which is thus non-uniform compared with the nominal confocal volume 23. Fig. 3c shows a scanned confocal volume 26 having a shape which is distorted with respect to the nominal confocal volume 23.

[0026] Mechanical misalignment and imperfection of optical and opto-mechanical components used are the main reasons for the non-uniformities of the confocal volumes represented in Figures 3a, 3b and 3c.

[0027] Fig. 4 shows a schematic representation of a scanned image of DNA binding array 31 of the type described in U.S. Patent No.5,143,854. Array 31 has a chess-board checkerboard array of fluorescent points 32 apt to emit fluorescence light when it is irradiated with excitation light. For the purpose of the following description it is convenient to distinguish two zones of array 31: a first zone 33 which extends from a diagonal 34 to the top right corner of array 31, and a second zone 35 which extends from diagonal 34 to the low left corner of array 31. Due to either inhomogeneous fluorophore density in the scanned object or inhomogeneous sensitivity of the confocal laser scan microscope vs. field of view, in the image represented by Fig. 4 fluorescent points 32 located in zone 33 of array 31 provide fluorescent light of lower intensity than fluorescent points 32 located in zone 35. The purpose of a reference device, a method and a system according to the invention is to evaluate quantitatively to which extent such variations of the intensity of the fluorescence light detected are due specifically to inhomogeneous sensitivity of the confocal laser scan microscope vs. field of view.

[0028] Fig. 5a shows a top view and Fig. 5b a cross-section of a first embodiment of a reference target device 41 according to the invention for characterizing and calibrating homogeneity and sensitivity of a confocal laser scan microscope for two-dimensional quantitative fluorescence measurement. In Figures 5a and 5b dimensions are indicated in millimeters.

[0029] The reference target device 41 shown by Figures 5a and 5b consists of a top glass plate 42 bonded onto a glass substrate 43. The 15.67 x 15.67 square millimeter glass substrate (thickness = 1 millimeter) has a 5 micrometer etched planar cavity 44 (hatched area). The glass top plate 42 (thickness = 0.7 millimeter) has two drilled wholes 45 respectively 46 for fluid in- and outlet. In another possible embodiment, a top glass plate 42 without drilled holes 45 and 46 may not be bonded onto a glass substrate 43.

[0030] Glass substrate 43 has e.g. identical dimensions and preferably the same optical properties as the substrate of DNA binding array 31 described above with reference to Fig. 4.

[0031] The cavity 44 of the target device is filled with dissolved fluorophores which have a predetermined concentration and a predetermined spatial distribution over the scanned area. This spatial distribution is determined by the structure of cavity 44, and not by the uniformly dissolved fluorophores themselves. In the example described with

reference to Figures 5a and 5b the spatial distribution of the fluorophores is a uniform one over the whole area of cavity 44.

[0032] Glass cover 42 of reference target device 41 shown by Figures 5a and 5b has identical dimensions and optical properties as a glass substrate of a given DNA binding array of the type described above with reference to Fig. 4. Reference target device 41 can therefore be scanned by the confocal laser scan microscope under the same optical conditions. The well defined size of the cavity and the controlled fluorophore concentration having a predetermined spatial distribution over the scanned area allows investigation of the measurement signal with respect to sensitivity (limit of detection) and homogeneity over the scan field of view. As mentioned above the spatial distribution of the dissolved fluorophores is determined by the structure of cavity 44, and not by the uniformly dissolved fluorophores themselves.

[0033] Fig. 6 shows the signal profile of row 588 of 1024 of the scanned image obtained with the reference device shown by Figures 5a and 5b when cavity 44 of the device, which cavity has a constant thickness over its whole extension, is filled with 200 ng/ml fluorescein TRIS solution (Fluorescein in aqueous 0.1 molar TRIS buffer pH 8.3). The image can be analyzed for sensitivity and for uniformity of the confocal laser scan microscope, as shown in Fig. 6 for the line profile of row 588 of 1024 (field of view = 10 x 10 square millimeter, pixel size = 10 micrometer, the resolution of the scanning is 1024 x 1024 pixel, the scan time is 126 seconds, the detection sensitivity of the transimpedance amplifier used is 10 microampere per volt, the cutoff or 6 dB frequency of the low-pass filter used with the transimpedance amplifier is 30 kHz, the integration interval dwell has a duration of 40 microseconds). As can be appreciated from Fig. 6 some noise signal is superposed on the line profile obtained. In Fig. 6 signal intensity is indicated in arbitrary units.

[0034] Fig. 7a shows a top view and Fig. 7b a cross-section of a second embodiment of a reference target device according to the invention for characterizing and calibrating homogeneity and spatial resolution of a confocal laser scan microscope.

[0035] In Figure 7a some dimensions in micrometer are indicated. In Figure 7b some dimensions in millimeters are indicated.

[0036] The reference target device 51 shown by Figures 7a and 7b consists of a top glass plate 52 on a glass substrate 53 having an area of 16 x 16 square millimeter. The upper surface of glass substrate 53 (thickness = 1 millimeter) has a 5 micrometer etched, microstructured depression forming a cavity 54 having a bottom inner surface. Cavity 54 is filled with uniformly dissolved fluorophores having a predetermined concentration and a predetermined spatial distribution over the area of cavity 54. This spatial distribution is not determined by the uniformly dissolved fluorophores themselves, but by the structure of cavity 54. Cavity 54 is covered by the glass top plate 52 which has a lower outer surface. The space comprised between the lower outer surface of plate 52 and the bottom inner surface of depression 54 has a thickness D which varies according to a predetermined function of the form  $D = f(x,y)$  over the entire area of depression 54. The latter space is at least partially filled with dissolved fluorophores.

[0037] Glass substrate 53 has e.g. identical dimensions and preferably the same optical properties as the substrate of DNA binding array 31 described above with reference to Fig. 4.

[0038] Glass cover 52 of reference target device 51 has identical optical properties as a glass substrate of a given DNA binding array 31 of the kind described above with reference to Fig. 4. Reference target device 51 can therefore be scanned by a confocal laser scan microscope under the same optical conditions.

[0039] The microstructured cavity 54 comprises different patterns of fluorescent zones. In Fig. 7a each non-fluorescent zone is represented by a shaded surface.

[0040] A first pattern of fluorescent zones comprises just two fluorescent zones each represented in Fig. 7 by a shaded square. In Fig. 7a fluorescent zones having this first pattern are located at each of the corner zones 55, 56, 57, 58 of reference target device 51. The measured signals corresponding to the intensity of fluorescent light emitted from these corner zones are evaluated in order to assess the degree of uniformity over the scan field of view of the scanning performed with a confocal laser scan microscope.

[0041] Zones 61 and 62 located at different rows of reference target device 51 have a second pattern of spatial distribution of fluorescent features. The measured signals corresponding to fluorescent light emitted from zones like 61 and 62 are evaluated in order to assess the resolution of the scanning performed with a confocal laser scan microscope.

[0042] Zones 63, 64 having the appearance of a group of bars having different inclination angles represent a third pattern of fluorescent features available on reference target device 51. The measured signals corresponding to fluorescent light emitted from a zone like zone 63 is evaluated in order to assess the dynamic signal behavior associated to the scanning performed with a confocal laser scan microscope.

[0043] The present invention relates to the reference target devices described above and shown in Figures 5a, 5b and 7a, 7b respectively, which are used for characterizing and / or calibrating a confocal laser scan microscope for two-dimensional, quantitative fluorescence measurement. Typical characteristics determined with a reference device, respectively a method, according to the invention are

- a) quantitative signal detection sensitivity,
- b) uniformity of the confocal volume over the scan field of view,
- c) spatial resolution of the scanning process, and
- c) dynamic behavior of the measured signal over the scan field of view, said measured signal corresponding to the fluorescent light received.

[0044] The above mentioned use of the invention for calibrating a confocal laser scan microscope substantially comprises

scanning a reference device according to the invention with a microscope to be calibrated in order to obtain a first set of measurement values,  
 processing said first set of measurement values in order to obtain correction factors,  
 storing said correction factors,  
 scanning a sample, e.g. a DNA binding array, with the calibrated microscope in order to obtain a second set of measurement values, and  
 correcting said second set of measurement values with said correction factors in order to obtain a third set of values which are free from deviations due to the performance of the scanner and which therefore more accurately correspond to characteristics of the particular sample examined.

[0045] Although preferred embodiments of the invention have been described above using specific terms, such description is for illustrative purposes only, and it is to be understood that changes and variations may be made without departing from the spirit or scope of the claims of this patent application.

List of reference numbers

[0046]

- 11 excitation laser beam
- 12 dichroic beam splitter
- 13 two-axis scan engine
- 14 lens
- 15 object plane
- 16 focused laser spot
- 17 fluorescent light
- 18 lens
- 19 detector pinhole
- 21 conjugate plane
- 22 photodetector
- 23 nominal confocal volume (cross-section in plan z-y)
- 24 scanned confocal volume (cross-section in plan z-y)
- 25 scanned confocal volume (cross-section in plan z-y)
- 26 scanned confocal volume (cross-section in plan z-y)
- 31 DNA binding array (located in object plane)
- 32 fluorescent point or fluorescent feature
- 33 zone
- 34 diagonal
- 35 zone
- 41 first embodiment of reference target device
- 42 top plate
- 43 bottom plate
- 44 cavity
- 45 hole
- 46 hole
- 51 second embodiment of reference target device
- 52 top plate
- 53 bottom plate
- 54 cavity
- 55 zone having a first pattern of fluorescent features

- 56 zone having a first pattern of fluorescent features
- 57 zone having a first pattern of fluorescent features
- 58 zone having a first pattern of fluorescent features
- 61 zone having a second pattern of fluorescent features
- 5 62 zone having a second pattern of fluorescent features
- 63 zone having a third pattern of fluorescent features
- 64 zone having a third pattern of fluorescent features

## 10 Claims

1. A reference device for evaluating the performance of a confocal laser scan microscope, said reference device comprising

15 (a) a substrate (43, 53), and  
(b) reference fluorescing matter distributed over a surface of said substrate (43, 53), said reference fluorescing matter having a predetermined spatial distribution over the latter surface.

2. A reference device according to claim 1, wherein said reference fluorescence matter has a constant thickness over said surface of said substrate.

3. A reference device according to claim 1, comprising

25 (a) a basis plate (43, 53) the upper surface of which has a depression (54), said depression having a constant thickness and extending over a substantial part of said upper surface, the bottom of said depression (54) having a bottom inner surface, and

(b) a cover plate (42, 52) which is optically transparent and which covers said depression of said basis plate, said cover plate having a lower outer surface,

30 the space comprised between said lower outer surface and said bottom inner surface of the depression of said basis plate having a constant thickness over the entire area of said depression (54),

(c) one or more zones within said space being completely filled with said reference fluorescing matter extending over the entire thickness of each zone.

4. A method for evaluating the performance of a confocal laser scan microscope of the kind used for performing a two dimensional quantitative fluorescence measurement of test matter distributed on a flat surface of a first substrate (31) said method comprising

performing a two-dimensional quantitative fluorescence measurement of a reference device with said microscope, said reference device comprising

40 (a) a second substrate (43, 53), and

(b) reference fluorescing matter distributed over a surface of said second substrate (43, 53), said reference fluorescing matter having a predetermined spatial distribution over the latter surface.

5. A method for evaluating the performance of a confocal laser scan microscope of the kind used for performing a two dimensional quantitative fluorescence measurement of test matter distributed on a flat surface of a first substrate (31) said method comprising

performing a two-dimensional quantitative fluorescence measurement of a reference device with said microscope, said reference device comprising

50 (a) a basis plate (43, 53) the upper surface of which has a depression (54), said depression having a constant thickness and extending over a substantial part of said upper surface, the bottom of said depression (54) having a bottom inner surface, and

(b) a cover plate (42, 52) which is optically transparent and which covers said depression of said basis plate, said cover plate having a lower outer surface,

55 the space comprised between said lower outer surface and said bottom inner surface of the depression of said basis plate having a constant thickness over the entire area of said depression (54),

(c) one or more zones within said space being completely filled with said reference fluorescing matter extending over the entire thickness of each zone.

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6. A method according to any of claims 4 or 5, wherein said first substrate is part of a DNA binding array or the like.

7. A system for evaluating the performance of a confocal laser scan microscope which is apt to be used for performing a two dimensional quantitative fluorescence measurement of test matter distributed on a flat surface of a substrate.  
said system comprising

a confocal laser scan microscope, and  
a reference device according to claim 1.



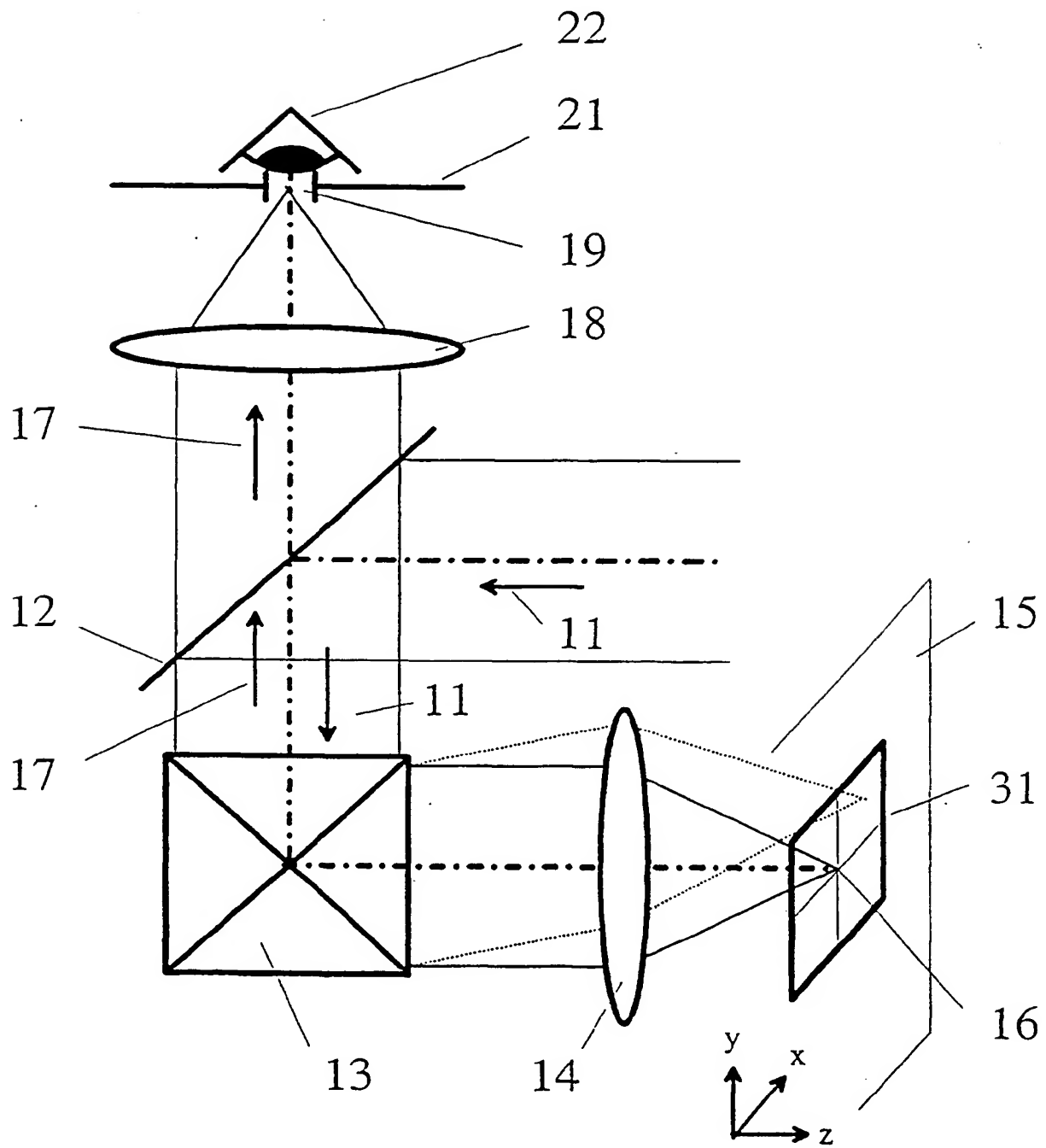


Fig. 1

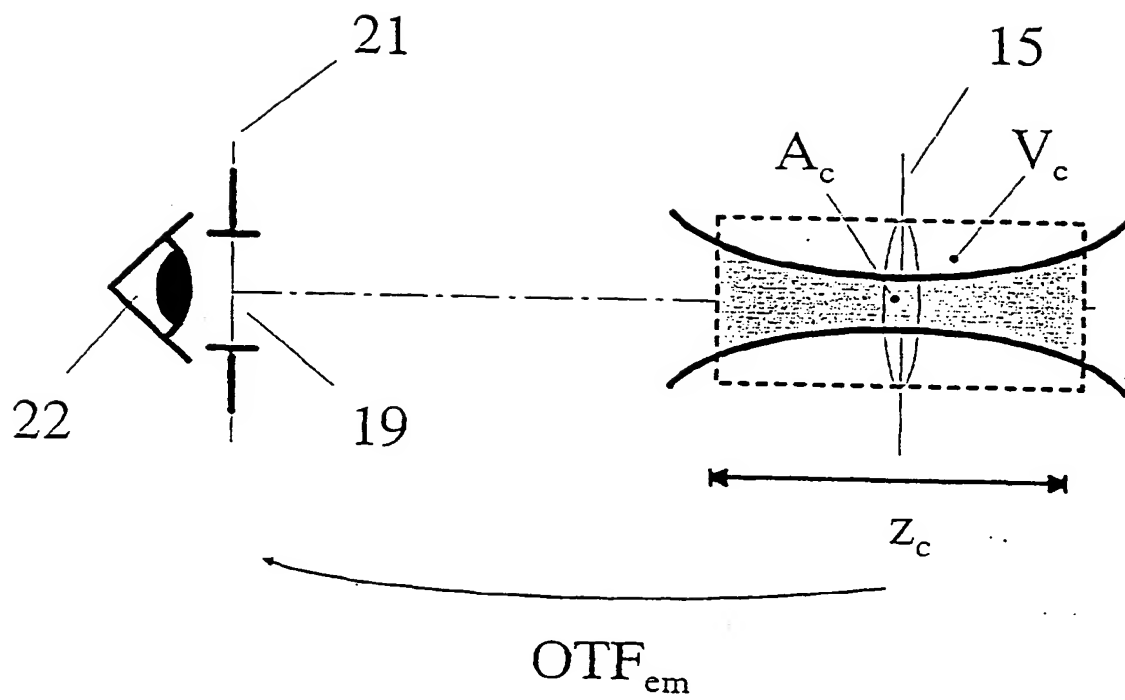


Fig. 2

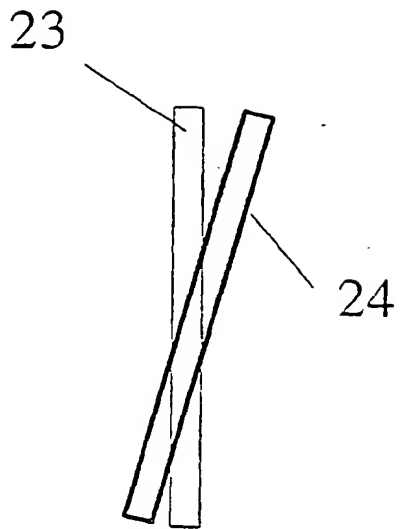


Fig. 3a

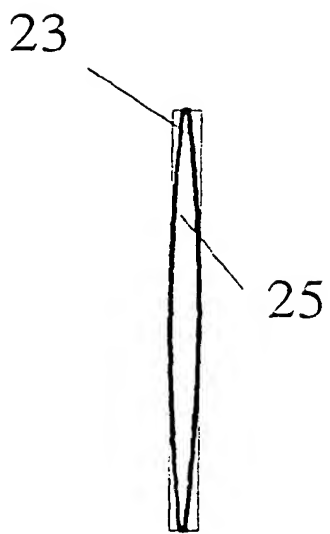


Fig. 3b

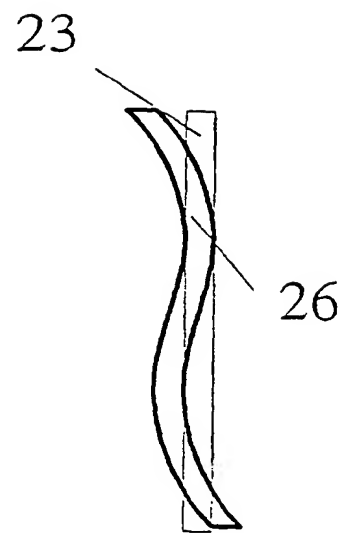


Fig. 3c

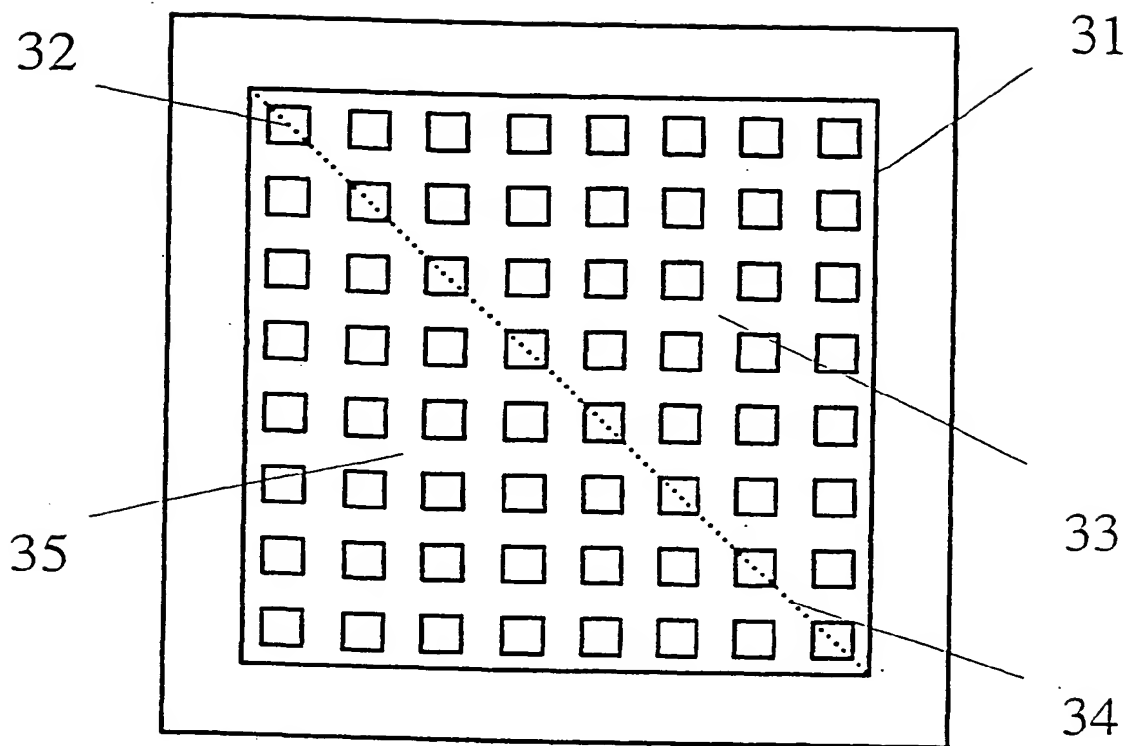


Fig. 4

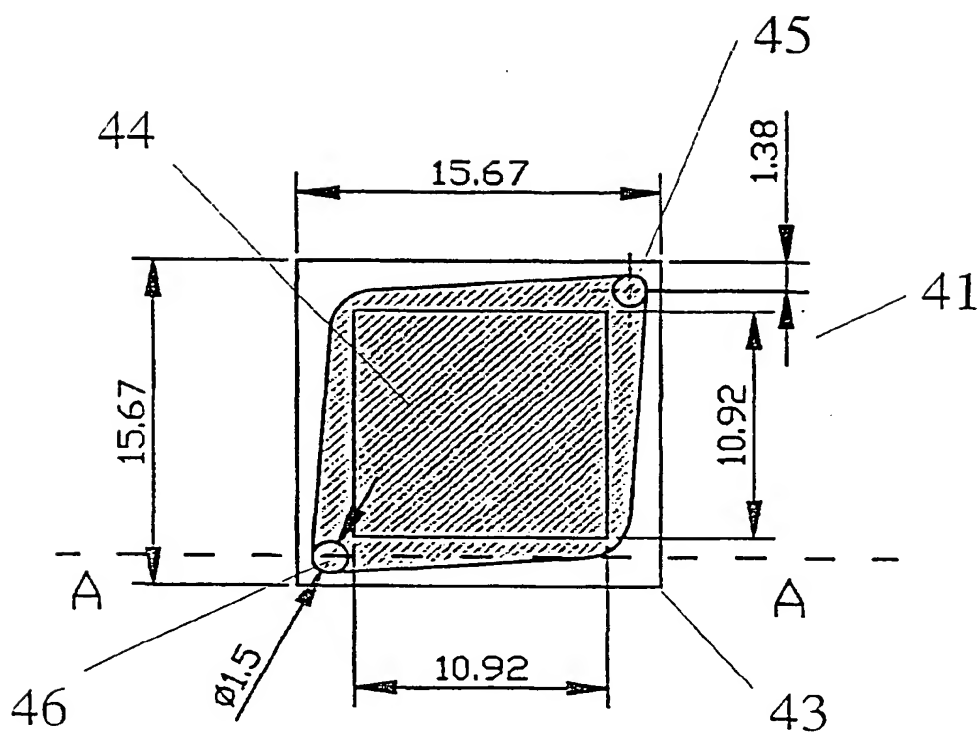


Fig. 5a

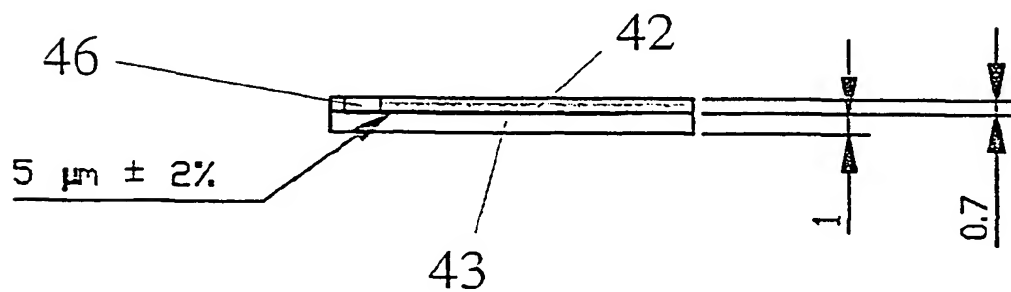


Fig. 5b

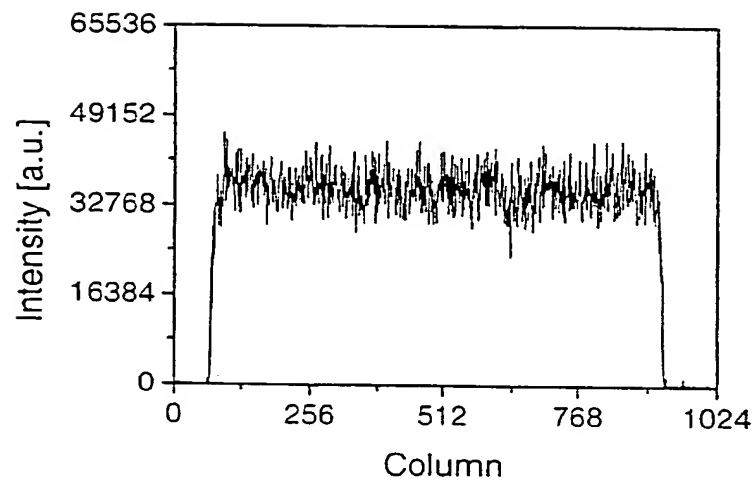


Fig. 6

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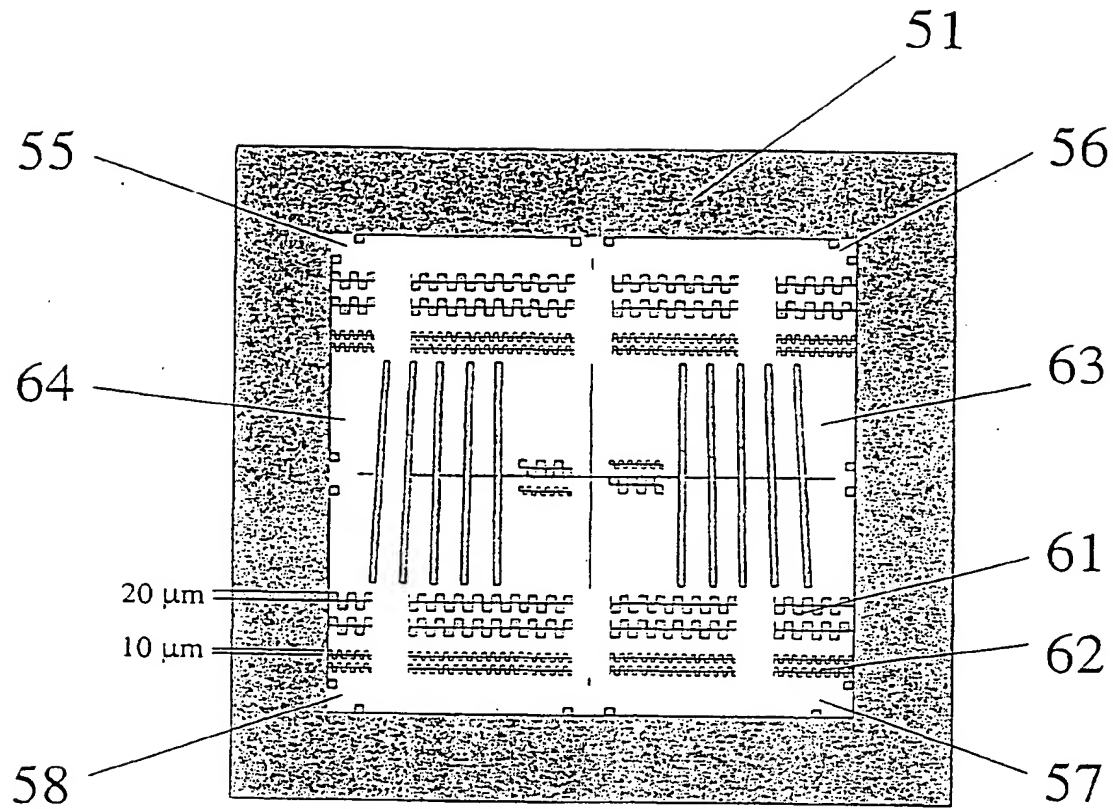


Fig. 7a

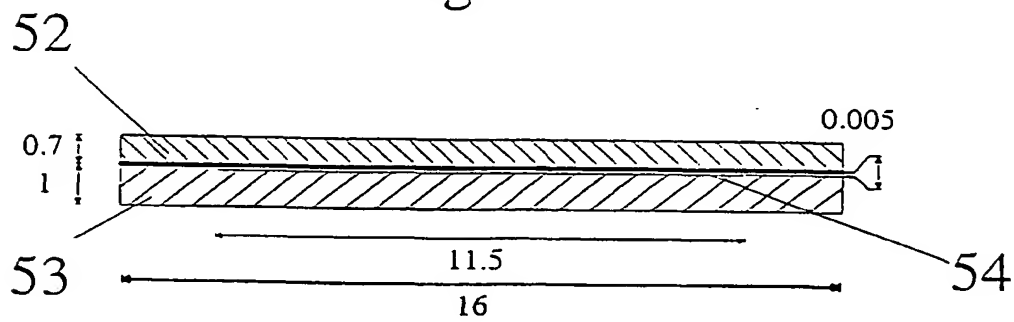


Fig. 7b



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# EUROPEAN SEARCH REPORT

Application Number  
EP 00 81 0496

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Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (IntCl7)
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A	JP 56 063242 A (YOKOGAWA DENKI SEISAKUSHO) 29 May 1981 (1981-05-29) * abstract *	3,5	
A	US 5 689 110 A (DIETZ) 18 November 1997 (1997-11-18) * abstract * * column 7, line 27 - line 36 * * column 17, line 44 - line 52 * * figures 5,6 *	1,4,5	TECHNICAL FIELDS SEARCHED (IntCl7) G01N
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-/--			
The present search report has been drawn up for all claims			
Place of search <b>THE HAGUE</b>		Date of completion of the search <b>13 October 2000</b>	Examiner <b>Thomas, R.M.</b>
<p>CATEGORY OF CITED DOCUMENTS</p> <p>X : particularly relevant if taken alone  Y : particularly relevant if combined with another document of the same category  A : technological background  O : non-written disclosure  P : intermediate document</p> <p>T : theory or principle underlying the invention  E : earlier patent document, but published on, or after the filing date  D : document cited in the application  L : document cited for other reasons  &amp; : member of the same patent family, corresponding document</p>			

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DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. CL.7)
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A	US 5 581 631 A (ORTYN) 3 December 1996 (1996-12-03) * abstract * * column 5, line 5 - line 18 * * figures 2,3 * -----	1,4,5	
The present search report has been drawn up for all claims			TECHNICAL FIELDS SEARCHED (Int. CL.7)
Place of search <b>THE HAGUE</b>		Date of completion of the search <b>13 October 2000</b>	Examiner <b>Thomas, R.M.</b>
<p><b>CATEGORY OF CITED DOCUMENTS</b></p> <p>X : particularly relevant if taken alone  Y : particularly relevant if combined with another document of the same category  A : technological background  O : non-written disclosure  P : intermediate document</p> <p>T : theory or principle underlying the invention  E : earlier patent document, but published on, or after the filing date  D : document cited in the application  L : document cited for other reasons  .....  &amp; : member of the same patent family, corresponding document</p>			

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EP 00 81 0496

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**Reference device for evaluating the performance of a confocal laser scanning microscope, and a method and system for performing that evaluation**

**Patent number:** EP1162450  
**Publication date:** 2001-12-12  
**Inventor:** SCHMID KARL (CH); SCHNELL URBAN (CH)  
**Applicant:** HOFFMANN LA ROCHE (CH)  
**Classification:**  
- **International:** G01N21/64; G02B21/16  
- **European:** G01N21/27E3, G02B21/00M4A  
**Application number:** EP20000810496 20000607  
**Priority number(s):** EP20000810496 20000607

**Also published as:**

 WO0194918 (A1)

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more >>

**Abstract of EP1162450**

A reference device for evaluating the performance of a confocal laser scan microscope. The reference device comprises a substrate (53) and reference fluorescing matter distributed over a surface of the substrate (53). The reference fluorescing matter has a predetermined spatial distribution over the latter surface.

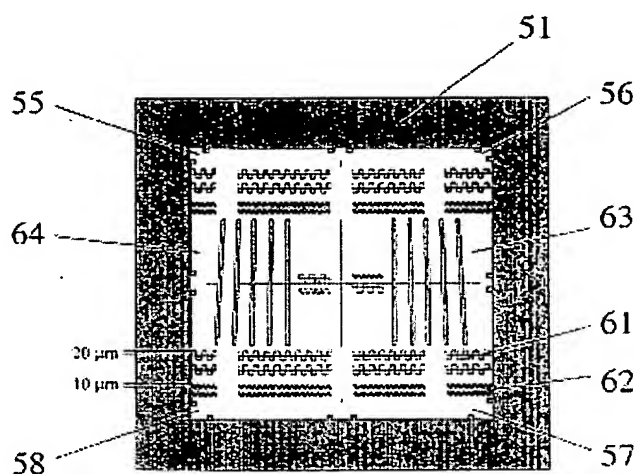


Fig. 7a

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